

Lab 1: DC Analysis of MOS Transistors
EECS 170LB
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1 NMOS Transistor

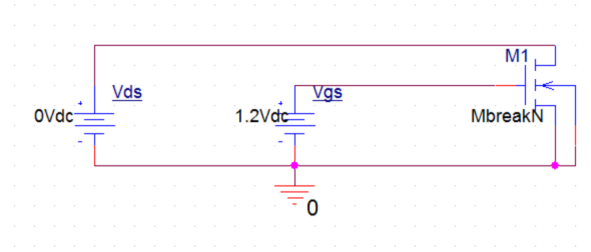


Figure 1: NMOS Circuit

In general, NMOS transistors have three operation modes. The first mode is cutoff, where $V_{GS} < V_T$, where V_T is the threshold voltage. The NMOS structure uses a MOS capacitor in the middle. Below the threshold voltage, not enough minority carriers exist in the bulk's conduction band to actually drive a substantial current. In the case of an NMOS transistor, the bulk is p-type, meaning minority carriers are electrons. Thus, when $V_{GS} < V_T$ in the NMOS, the drain current due to the minority carrier electrons is effectively 0mA.

By setting a voltage at the gate, the majority carrier holes in the p-type substrate are pushed away, exposing the negative acceptor ions beneath them. A depletion region forms as a result. Once the gate voltage exceeds the threshold voltage, valence band electrons in the depletion region acquire enough energy to jump the bandgap and become conduction electrons. As a result, an inversion layer develops in the bulk between the source and the drain. A drain current can now flow.

When $V_{GS} > V_T$, a bifurcation occurs. The NMOS can either enter the triode or saturation mode. In the triode mode, the NMOS acts as an approximately linear resistor. The conductivity, and therefore the resistance, can be controlled by varying the number of minority carrier electrons by changing the gate voltage. By applying V_{DS} , a current is then driven through the somewhat linear resistance. For small values of V_{DS} , the resistance is basically linear. For larger values, the resistance begins to act less linear, but still exhibits similar behavior. The MOSFET remains in this triode mode for as long as $V_{DS} < V_{GS} - V_T$. However, once $V_{DS} > V_{GS} - V_T$, the MOSFET enters saturation. In the saturation mode, the NMOS does not have enough carrier electrons in the channel to support the desired current that should be present given V_{DS} . At this point, increasing V_{DS} leads to no additional current past the saturation current.

However, in the saturation mode, as V_{DS} is increased, more electrons concentrate toward the source than the drain. At saturation, no excess carrier electrons exist at the drain, and the channel "pinches-off" as a result. Past this point, the channel length decreases because more and more of the area closer to

the drain becomes unoccupied by electrons as they move toward the source. As the channel becomes shorter, its resistance decreases, and the current increases linearly. This effect is known as channel length modulation. So, the saturation current looks like:

$$i_D = \frac{k_n}{2}(V_{GS} - V_T)^2(1 + \lambda V_{DS}) \quad (\lambda : \text{constant}) \quad (1)$$

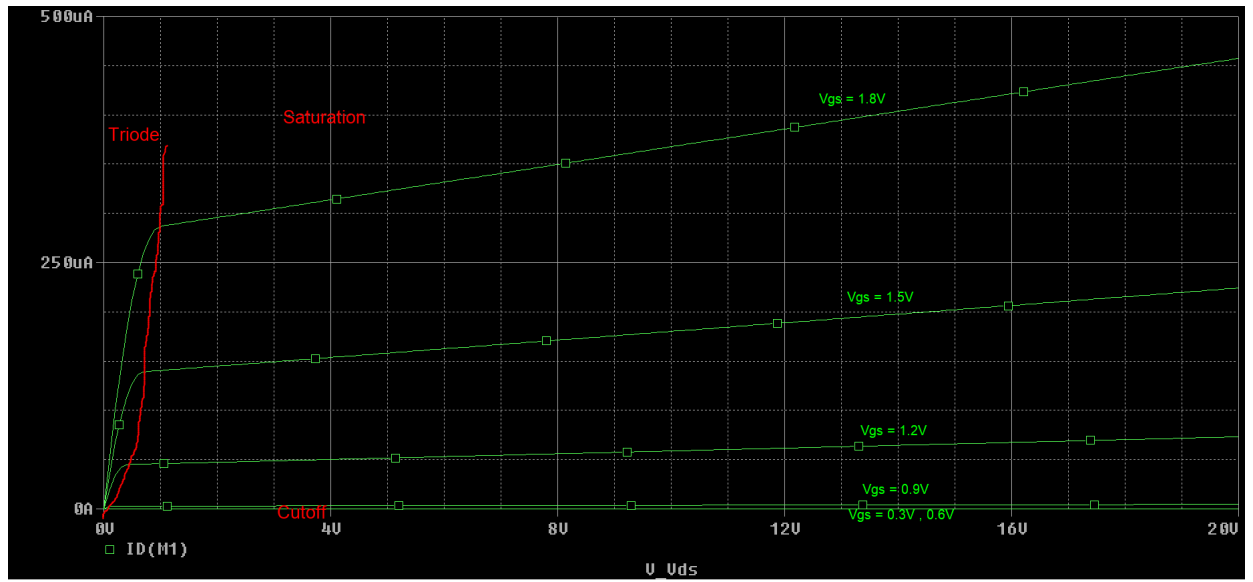


Figure 2: NMOS DC Sweep - i_D vs V_{DS}



Figure 3: NMOS DC Sweep - i_D vs V_{GS}

When sweeping through increasing values of V_{GS} , the transistor goes from cutoff mode to saturation mode and eventually to triode mode. In the saturation mode, ignoring channel length modulation effects, the current varies approximately quadratically with V_{GS} :

$$i_D = \frac{k_n}{2}(V_{GS} - V_T)^2 \quad (2)$$

Once V_{GS} becomes sufficiently high, the transistor enters triode mode. At this point, the current has a linear dependence on V_{GS} :

$$i_D = k_n \left((V_{GS} - V_T) - \frac{V_{DS}}{2} \right) V_{DS} \quad (3)$$

So, the transistor should remain at zero, then grow quadratically, and then linearly. This is precisely the behavior observed in figure (3). At higher V_{DS} values, the transistor remains in saturation for longer due to the fact that $V_{DS} > V_{GS} - V_T$ remains true for more values of V_{GS} . So, the drain attains higher values before entering the linear triode region. As a result, the slope of the curve when in the triode region increases with V_{DS} . However, as V_{DS} becomes large, the i_D versus V_{GS} curves asymptotically approach the curve $i_D = \frac{k_n}{2}(V_{GS} - V_T)^2$ for all V_{DS} values. When V_{DS} is large, the transistor may not enter the triode region in this V_{GS} range. This is why the curves begin to converge for larger V_{DS} values.

2 PMOS Transistor

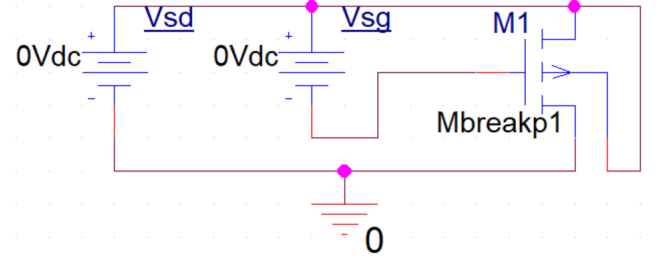


Figure 4: PMOS Circuit

The PMOS transistor has behavior similar to the NMOS, but with a few slight deviations. When the MOS capacitor is charged at a voltage lower than the source, holes are attracted to form the channel. The terminal from which carriers flow shall be called the source. So, for the PMOS, the source terminal should be higher than the drain terminal so that holes can flow from high to low potential from the source. Therefore, current flows into the drain, unlike in an NMOS transistor, where the current flows away from the drain. So, the NMOS current plot should be flipped over the x-axis for the PMOS since the current is negative.

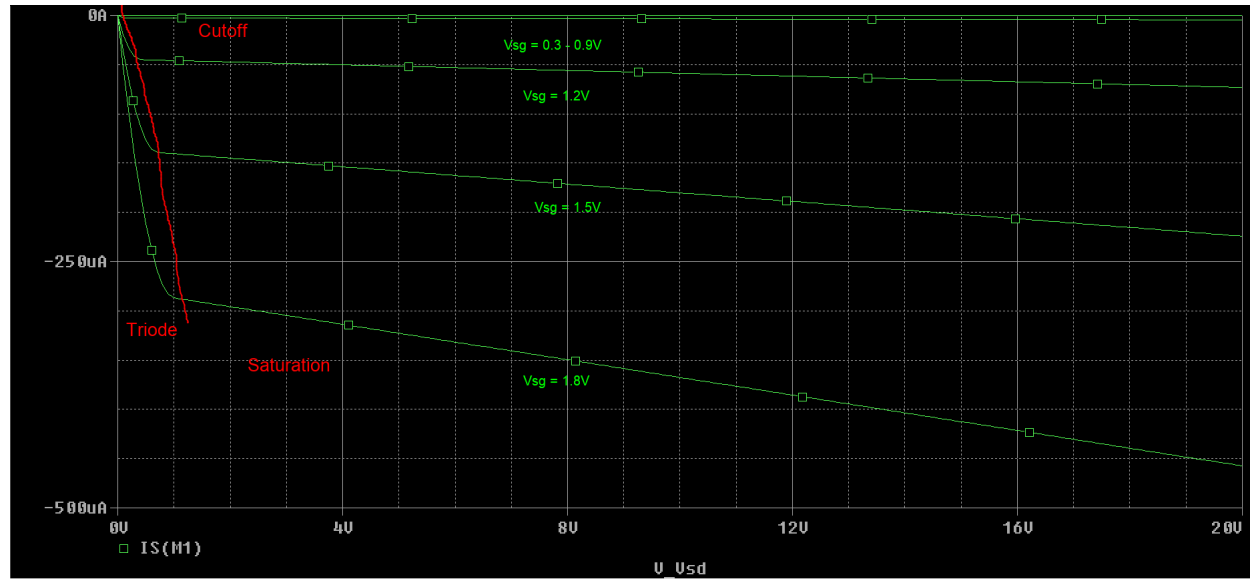


Figure 5: PMOS i_D versus V_{SD}

If only the magnitude is observed, the plots should turn out to be the same.

The voltages applied to the transistor are essentially the same, with source and drain terminals flipped, giving rise to the factor of -1 difference between the NMOS and PMOS current plots. For the SPICE models used, the PMOS has a process transconductance parameter $k_p \approx \frac{k_n}{2}$. The PMOS's process transconductance parameter is given by:

$$k'_p = \mu_p C_{ox} \quad (4)$$

The NMOS's parameter is:

$$k'_n = \mu_n C_{ox} \quad (5)$$

Here, C_{ox} is the oxide capacitance density per area, μ_n is the electron mobility, and μ_p is the hole mobility. k'_p is about half the magnitude of k'_n because the hole mobility μ_p is about half the magnitude of μ_n .

The drain currents in transistors depend on the MOSFET transconductance parameter, which for a PMOS is given by:

$$k_p = k'_p \frac{W}{L} \quad (6)$$

W is the transistor's channel width, and L is the channel length. Making the width W twice the width of the corresponding NMOS model compensates for the lower process transconductance parameter. Thus, the PMOS's $|i_D|$ curve should be the same as the NMOS's. The factor of -1 difference for the i_D plots should be the only difference between the two.

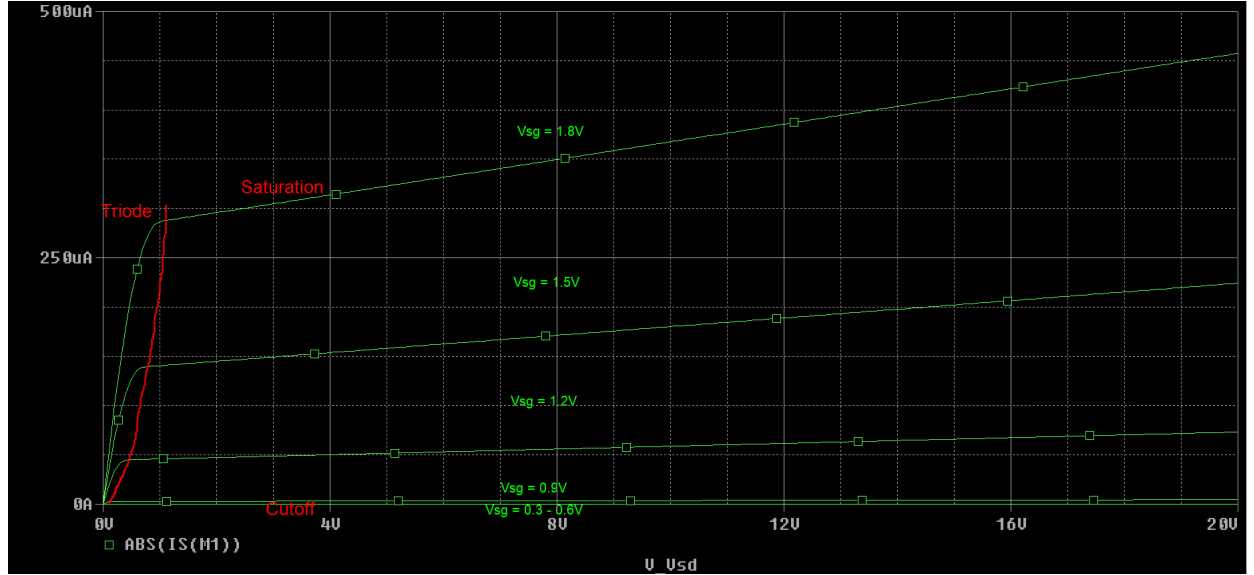


Figure 6: PMOS $|i_D|$ vs V_{SD}

When sweeping V_{SD} , the mechanics of the PMOS transistor are nearly identical besides the fact that holes are the charge carrier. As a result, the drain current differs by a factor of -1 . The $|i_D|$ curve is essentially the same as for the NMOS for the same reasons as above.

The same logic applies to the i_D versus V_{SG} curves. The difference is in the factor of -1 .

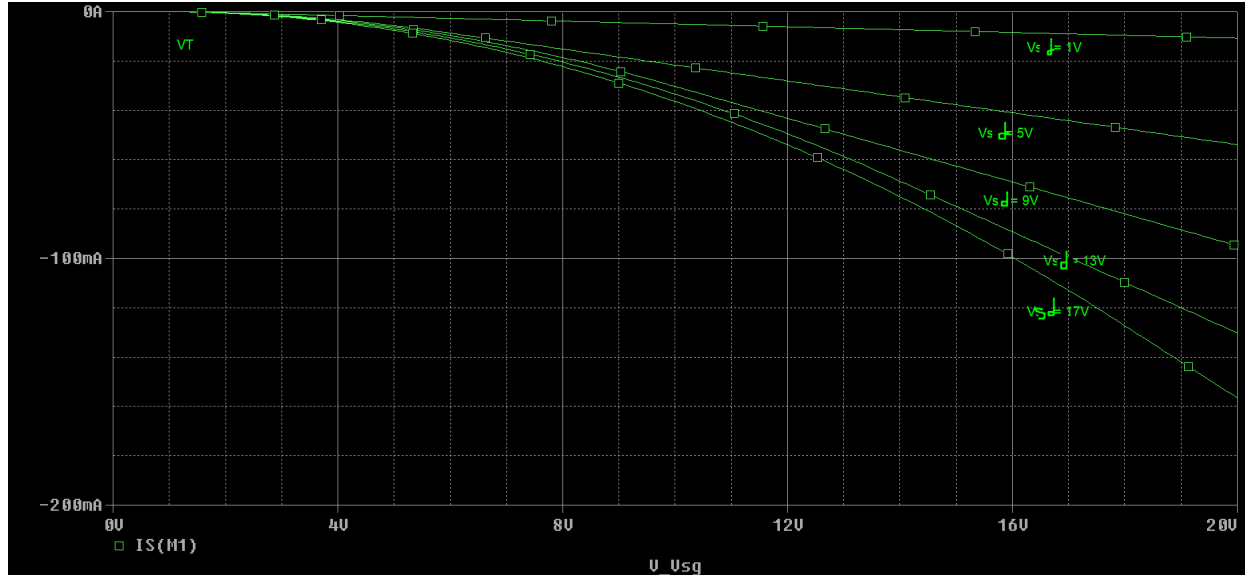


Figure 7: PMOS i_D vs V_{SG}

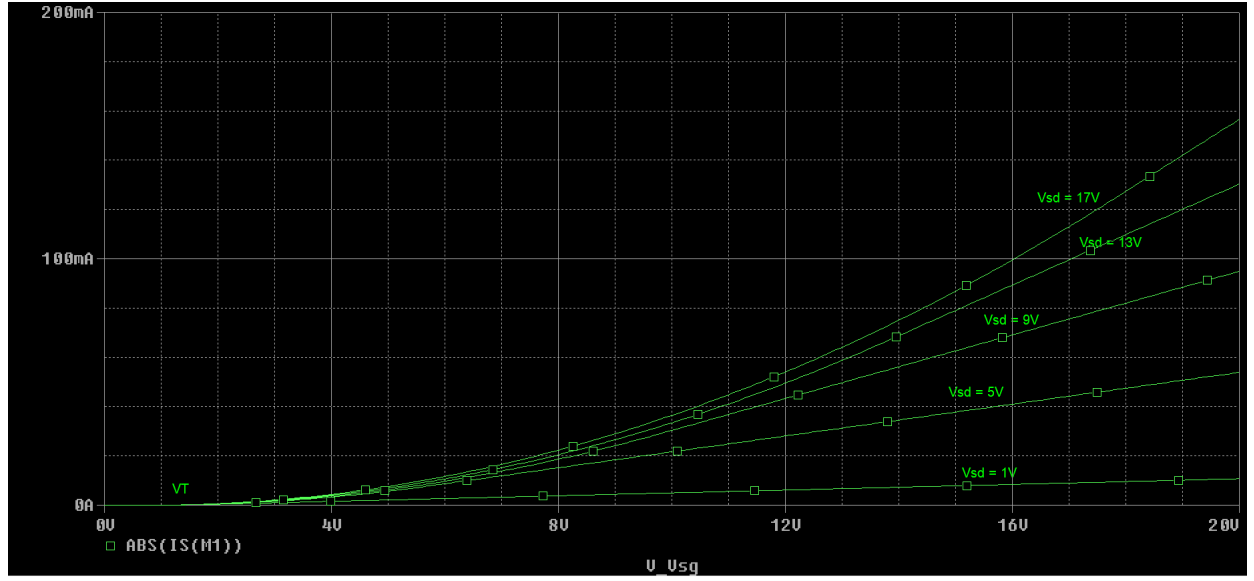


Figure 8: PMOS $|i_D|$ vs V_{SG}

3 Diode-Connected NMOS

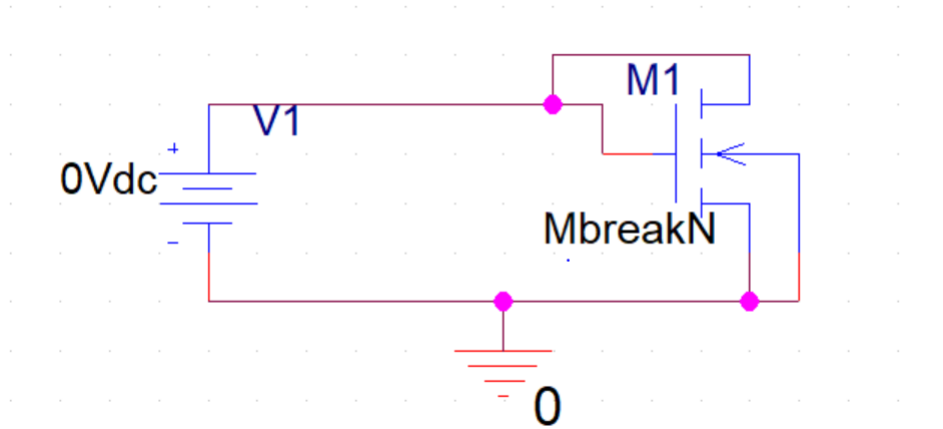


Figure 9: Diode-Connected NMOS Circuit

Two operation modes are possible for the circuit in figure (9). In the first case, consider $V_{GS} < V_T$. At this point, the transistor is in cutoff mode, and no current flows. For the second case, $V_{GS} > V_T$. Since $V_G = V_D$ and $V_{GS} > V_{GS} - V_T$, $V_{DS} > V_{GS} - V_T$. This satisfies the condition for saturation.

So, the transistor is either in cutoff or in saturation. So, neglecting channel length modulation effects, the transistor's drain current is given by:

$$i_D = \begin{cases} \frac{k_n}{2}(V_{GS} - V_T)^2 & V_{GS} > V_T \\ 0 & V_{GS} < V_T \end{cases} \quad (7)$$

This current behavior mimics that of a pn-junction diode, but with a current that varies quadratically instead of exponentially with the applied voltage V_{GS} . The transistor, like a diode, requires a certain voltage in order to "turn-on", specifically V_T . Once this voltage is exceeded, the transistor is activated and immediately enters the saturation region. From this, increasing V_{GS} leads to quadratically larger drain currents, just like how increasing the applied voltage leads to exponentially growing diode currents.

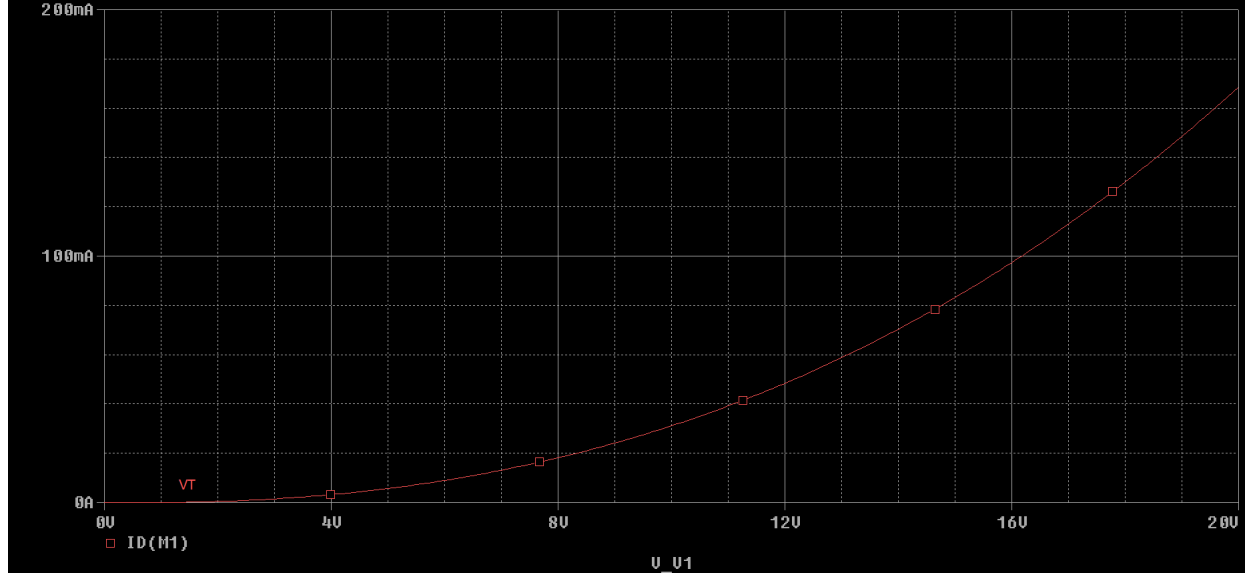


Figure 10: DC Sweep of Circuit in Figure (9)

4 Current Mirror

4.1 First Current Mirror Circuit

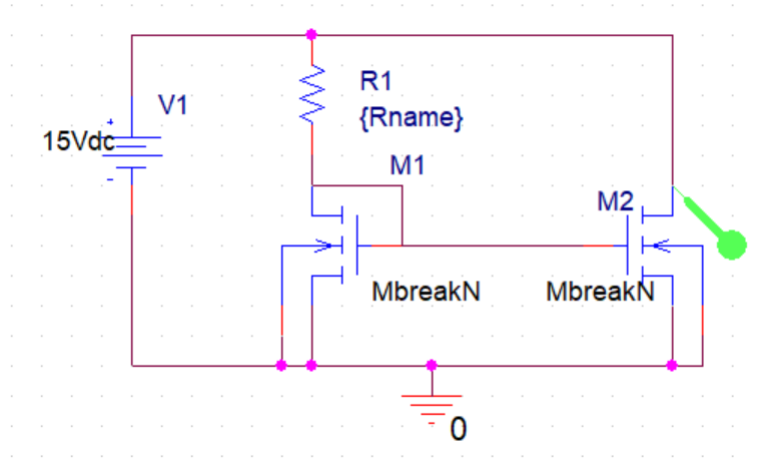


Figure 11: First Current Mirror Circuit

Assume transistors M_1 and M_2 in figure (11) are identical. Because M_1 is a diode-connected MOSFET, if $V_{DS} = V_{GS} > V_T$, then M_1 operates in saturation. Assume that M_1 is not in cutoff and is therefore in saturation. M_1 's drain current shall be called i_{ref} , and M_2 's i_{out} .

Because the gates of M_1 and M_2 are connected and both of their sources are grounded, V_{GS} is the same for each. Since M_1 and M_2 are identical transistors, their V_T values are identical as well. So, if current can flow through M_1 's drain, then M_2 must also be active because $V_{GS} > V_T$ in both cases. M_2 's V_{DS} certainly exceeds M_1 's V_{DS} since M_2 's drain is directly connected to the supply voltage rather than an intermediary resistor. Since M_1 is in saturation, $V_{DS} > V_{GS} - V_T$ is the condition for saturation, and M_2 's V_{DS} exceeds M_1 's V_{DS} , then M_2 must also be in saturation.

Since both transistors are in saturation, have the same V_{GS} value, and have identical structures, the following must be true:

$$\frac{i_{ref}}{i_{out}} = \frac{\frac{k_n}{2}(V_{GS} - V_T)^2}{\frac{k_n}{2}(V_{GS} - V_T)^2} = 1 \rightarrow i_{ref} = i_{out} \quad (8)$$

This circuit is called a "current mirror" because of the property demonstrated in equation (8). Given any input current i_{ref} , the output current i_{out} must be the same. Changing the dimensions of the transistors relative to one another can alter the output current by a constant factor [1].

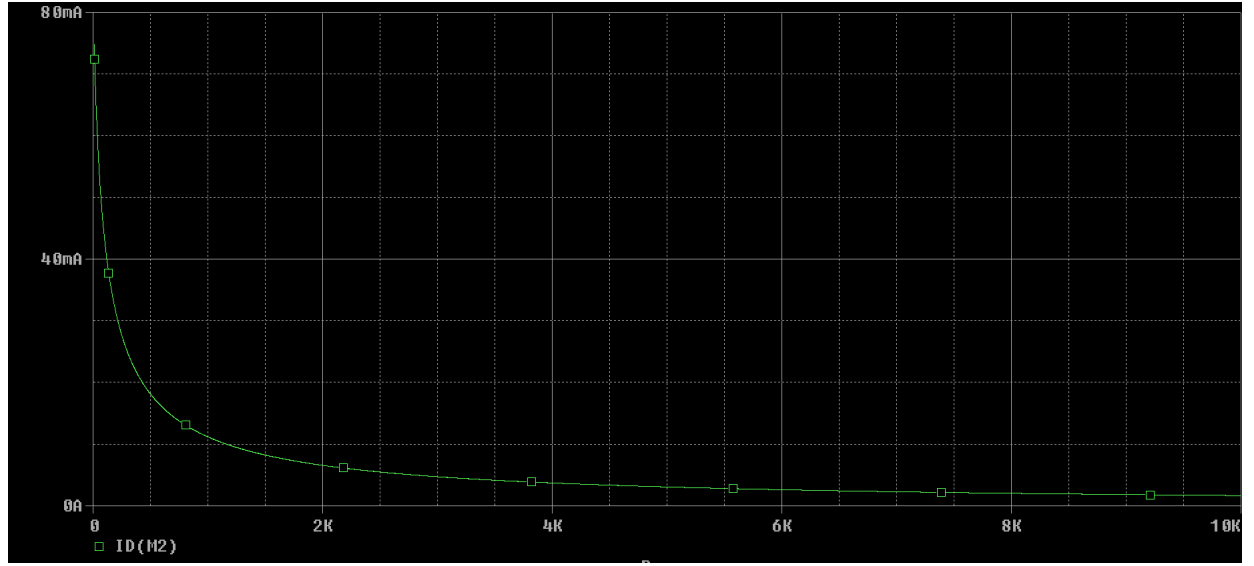


Figure 12: i_{out} versus R_1 for Current Mirror in Figure (11)

In the extreme case where R_1 is a short and $V_T < V_{DD}$ (as it should be), where V_{DD} is the supply voltage, then $V_{GS} = V_{DD} > V_T$. Thus, M_1 and therefore M_2 are both in the saturation region. At this point, V_{GS} is maximum, and the maximum i_D should flow.

On the other hand, if R_1 is an open circuit, current cannot flow through M_1 's drain. Furthermore, current cannot flow from M_1 's gate to its drain because it would need to be supplied by current from one of the transistors' gates. Therefore, M_1 cannot receive any drain current. So, as $R_1 \rightarrow \infty$, $i_D = 0$. Thus, as R_1 is increased, it absorbs more and more of the supply voltage V_{DD} until M_1 operates in cutoff mode. Thus, the i_{ref} versus R_1 curve should be downward sloping.

4.2 Second Current Mirror Circuit



11

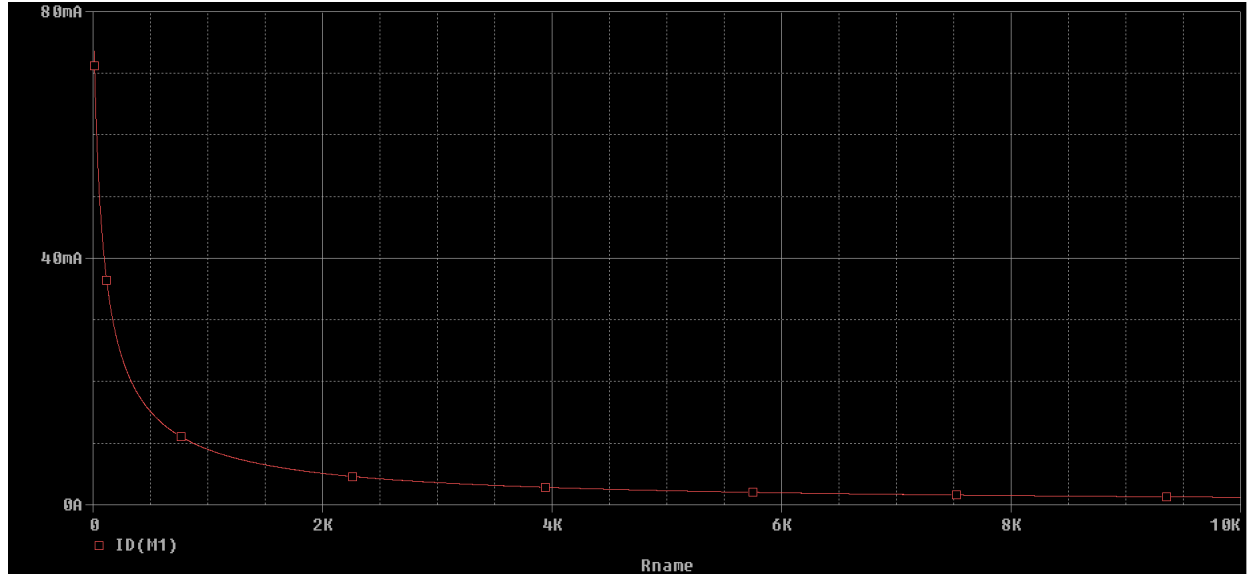


Figure 14: $i_{D,M1}$ versus R_1

Since the currents through M_2 and M_3 should each be i_{ref} , their sum should be about $2i_{ref}$. For instance, at $R_1 = 10\Omega$, i_{ref} from figure (14) is about 75mA. The sum of the currents in figure (15) is about 150mA, twice that value. The curve follows the same trend, but with double the values for this reason.

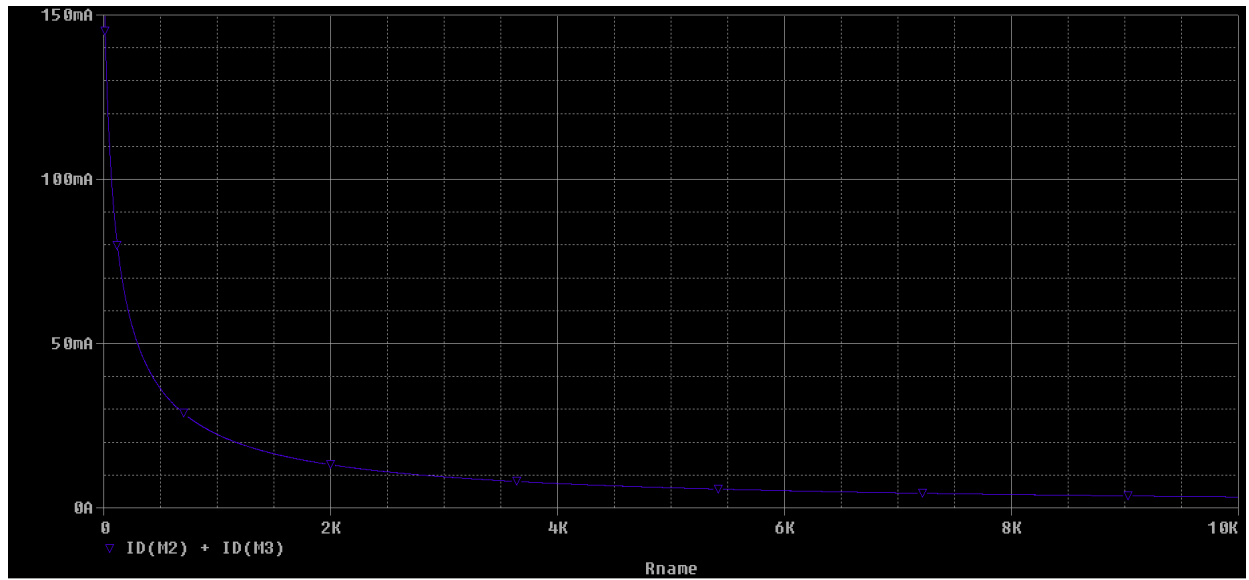


Figure 15: $i_{D,M2} + i_{D,M3}$ versus R_1

References

- [1] <http://inf-server.inf.uth.gr/courses/ce433/tutorials/mosfet%20current%20mirror.pdf>.